Application/Control No. O9/534,550 Reexamination SHUE ET AL. Examiner Douglas W Owens Applicant(s)/Patent Under Reexamination SHUE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
X	Α	US-5,110,752	05-1992	Lu	437	47
X	В	US-5,272,367	12-1993	Dennison et al.	257	306
Х	С	US-5,656,529	08-1997	Fukase	438	398
X	D	US-5,907,772	05-1999	lwasaki	438	253
Х	Е	US-6,028,002	02-2000	Thakur	438	647
Х	F	US-6,177,716	01-2001	Clark	257	532
X	G	US-5,563,090	10-1996	Lee et al.	437	60
X	Н	US-5,962,886	10-1999	Mori et al.	257	309
X	ı	US-6,163,046	12-2000	Okumura et al.	257	306
X	J	US-5,966,627	10-1999	Brady et al.	438	542
X	К	US-6,417,565	07-2002	Komatsu	257	750
X	L	US-6,124,614	09-2000	Ryum et al.	257	347
	М	US-6,407,420	06-2002	Yamanaka et al.	257	296

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
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NON-PATENT DOCUMENTS

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Notice of References Cited

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